

<b>Notice of References Cited</b>	Application/Control No. 09/996,129	Applicant(s)/Patent Under Reexamination SWEITZER ET AL.	
	Examiner Srirama Channavajjala	Art Unit 2177	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0042751	04-2002	Sarno, Anthony	705/26
	B	US-6,662,357	12-2003	Bowman-Amuah, Michel K.	717/120
	C	US-2003/0101250	05-2003	Sweitzer et al.	709/223
	D	US-2002/0191014	12-2002	Hsieh et al.	345/738
	E	US-6,370,578	04-2002	Revashetti et al.	709/224
	F	US-6,700,590	03-2004	DeMesa et al.	345/744
	G	US-2002/0120917	08-2002	Abrari et al.	717/110
	H	US-6,151,707	11-2000	Hecksel et al.	717/178
	I	US-2002/0169658	11-2002	Adler, Richard M.	705/10
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	ep0869449	10-1998	European	Dove Lee et al.,	17/50
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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